

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. ASA-867-04		SERIAL NO.		
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Y. MARUYAMA et al				
				FILING DATE July 23, 2003		GROUP 2653		
<b>U.S. PATENT DOCUMENTS</b>								
* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)	
AH	AA	5,717,547	02/1998	Young				
	AB	6,069,774	05/2000	Arisaka				
	AC	6,282,064	08/2001	Palmer				
	AD	5,737,152	04/1998	Balakrishnan				
	AE							
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK							
<b>FOREIGN PATENT DOCUMENTS</b>								
		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
AH	AL	WO 96/42080	12/27/96	WIPO International Application			<input type="checkbox"/>	<input type="checkbox"/>
	AM						<input type="checkbox"/>	<input type="checkbox"/>
	AN						<input type="checkbox"/>	<input type="checkbox"/>
	AO						<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)</b>								
AH	AR	NIKKEI ELECTRONICS, "Recording Density by MR Head Available at 5 Gbits/(inch)", April 6, 1998, pp. 155-165.						
	AS	Japanese Electronic Information Communication Institute Technical Research Report, "JIKI KIROKU", published Oct. 15, 1998, pp. 7-12.						
	AT	NIKKEI ELECTRONICS, April 6, 1998, page 168.						
EXAMINER A. Heinz				DATE CONSIDERED 3/1/05				
* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

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	AA						
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	AJ						
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<b>FOREIGN PATENT DOCUMENTS</b>							
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
	AL					<input type="checkbox"/>	<input type="checkbox"/>
	AM					<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>
<b>OTHER DOCUMENTS</b> <i>(Including Author, Title, Date, Pertinent Pages, etc.)</i>							
A/H	AR	Japanese Applied Magnetic Institute, 22nd Lecture held in 1998.					
	AS						
	AT						
EXAMINER <i>A. Heinz</i>				DATE CONSIDERED <i>3/1/05</i>			
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